



SEMiX® 2s

Trench IGBT Modules

SEMiX302GB066HDs

Features

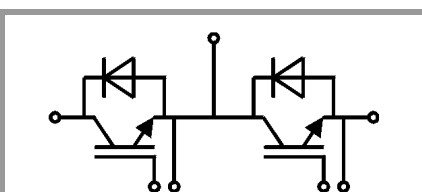
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- UL recognised file no. E63532

Typical Applications*

- Matrix Converter
- Resonant Inverter
- Current Source Inverter

Remarks

- Case temperature limited to $T_C=125^{\circ}\text{C}$ max.
- Product reliability results are valid for $T_J=150^{\circ}\text{C}$
- For short circuit: Soft R_{Goff} recommended
- Take care of over-voltage caused by stray inductance



GB

Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT				
V _{CES}	T _J = 25 °C		600	V
I _C	T _J = 175 °C	T _c = 25 °C	379	A
		T _c = 80 °C	286	A
I _{Cnom}			300	A
I _{CRM}	I _{CRM} = 2xI _{Cnom}		600	A
V _{GES}			-20 ... 20	V
t _{psc}	V _{CC} = 360 V V _{GE} ≤ 15 V T _J = 150 °C V _{CES} ≤ 600 V		6	μs
T _J			-40 ... 175	°C
Inverse diode				
I _F	T _J = 175 °C	T _c = 25 °C	419	A
		T _c = 80 °C	307	A
I _{Fnom}			300	A
I _{FRM}	I _{FRM} = 2xI _{Fnom}		600	A
I _{FSM}	t _p = 10 ms, sin 180°, T _J = 25 °C		1400	A
T _J			-40 ... 175	°C
Module				
I _{t(RMS)}	T _{terminal} = 80 °C		600	A
T _{stg}			-40 ... 125	°C
V _{isol}	AC sinus 50Hz, t = 1 min		4000	V

Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
V _{CE(sat)}	I _C = 300 A	T _j = 25 °C		1.45	1.85	V
	V _{GE} = 15 V chipelevel	T _j = 150 °C		1.7	2.1	V
V _{CE0}		T _j = 25 °C		0.9	1	V
		T _j = 150 °C		0.85	0.9	V
r _{CE}	V _{GE} = 15 V	T _j = 25 °C		1.8	2.8	mΩ
		T _j = 150 °C		2.8	4.0	mΩ
V _{GE(th)}	V _{GE} =V _{CE} , I _C = 4.8 mA		5	5.8	6.5	V
I _{CES}	V _{GE} = 0 V	T _j = 25 °C		0.15	0.45	mA
	V _{CE} = 600 V	T _j = 150 °C				mA
C _{ies}	V _{CE} = 25 V V _{GE} = 0 V	f = 1 MHz		18.5		nF
C _{oes}		f = 1 MHz		1.15		nF
C _{res}		f = 1 MHz		0.55		nF
Q _G	V _{GE} = - 8 V...+ 15 V			2400		nC
R _{Gint}	T _j = 25 °C			1.00		Ω
t _{d(on)}	V _{CC} = 300 V			110		ns
t _r	I _C = 300 A			85		ns
E _{on}	T _j = 150 °C			11.5		mJ
t _{d(off)}	R _{G on} = 5.1 Ω			820		ns
t _f	R _{G off} = 5.1 Ω			70		ns
E _{off}				15		mJ
R _{th(j-c)}	per IGBT				0.16	K/W



SEMiX® 2s

Trench IGBT Modules

SEMiX302GB066HDs

Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- UL recognised file no. E63532

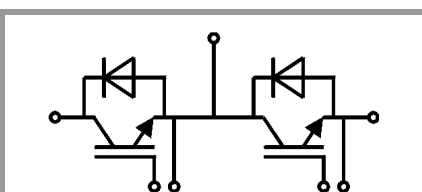
Typical Applications*

- Matrix Converter
- Resonant Inverter
- Current Source Inverter

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_J=150^\circ\text{C}$
- For short circuit: Soft R_{Goff} recommended
- Take care of over-voltage caused by stray inductance

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
V _F = V _{EC}	I _F = 300 A	T _j = 25 °C		1.4	1.60	V
	V _{GE} = 0 V chip	T _j = 150 °C		1.4	1.6	V
V _{F0}		T _j = 25 °C	0.9	1	1.1	V
		T _j = 150 °C	0.75	0.85	0.95	V
r _F		T _j = 25 °C	1.0	1.3	1.7	mΩ
		T _j = 150 °C	1.5	1.8	2.2	mΩ
I _{RRM}	I _F = 300 A	T _j = 150 °C		240		A
Q _{rr}	di/dt _{off} = 3600 A/μs	T _j = 150 °C		35		μC
E _{rr}	V _{GE} = -8 V	T _j = 150 °C		7.5		mJ
	V _{CC} = 300 V	T _j = 150 °C				
R _{th(j-c)}	per diode				0.19	K/W
Module						
L _{CE}				18		nH
R _{CC'+EE'}	res., terminal-chip	T _C = 25 °C		0.7		mΩ
		T _C = 125 °C		1		mΩ
R _{th(c-s)}	per module			0.045		K/W
M _s	to heat sink (M5)		3		5	Nm
M _t	to terminals (M6)		2.5		5	Nm
w					250	g
Temperature sensor						
R ₁₀₀	T _c =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{100/125}	R _(T) =R ₁₀₀ exp[B _{100/125} (1/T-1/T ₁₀₀)]; T[K];			3550 ±2%		K



GB

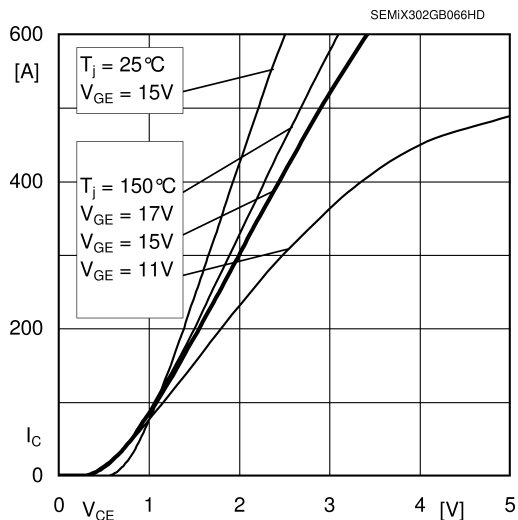


Fig. 1: Typ. output characteristic, inclusive $R_{CC'} + EE'$

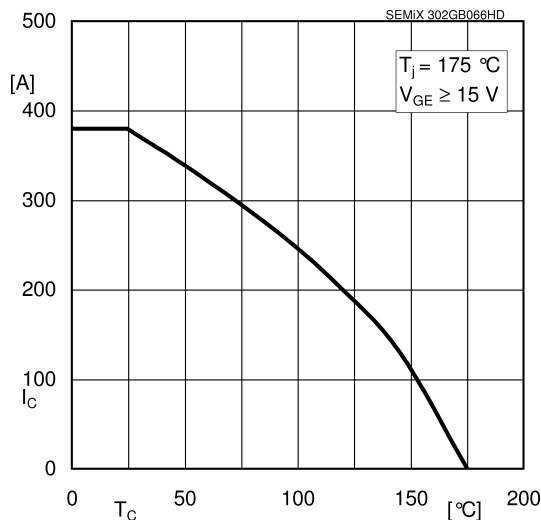


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

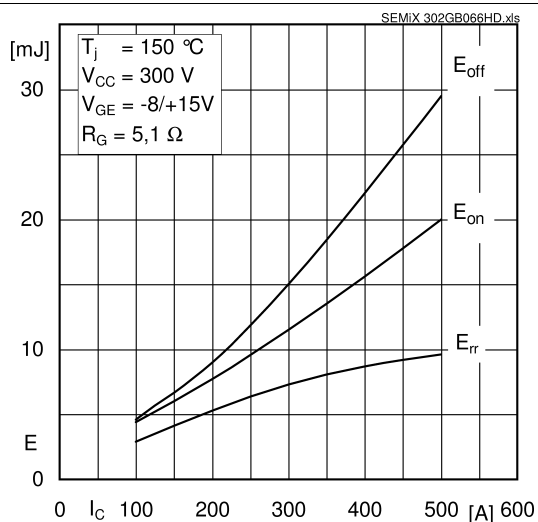


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

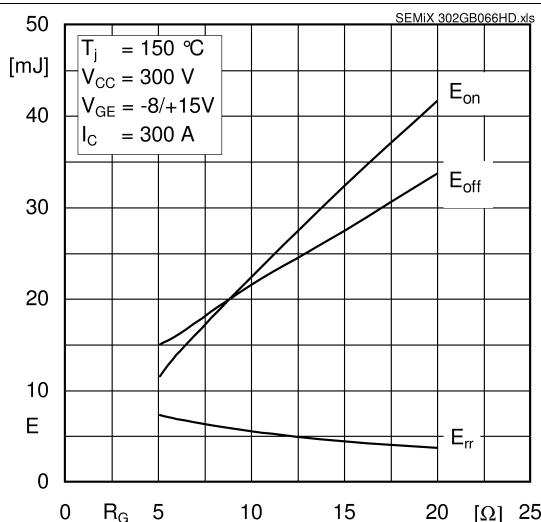


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

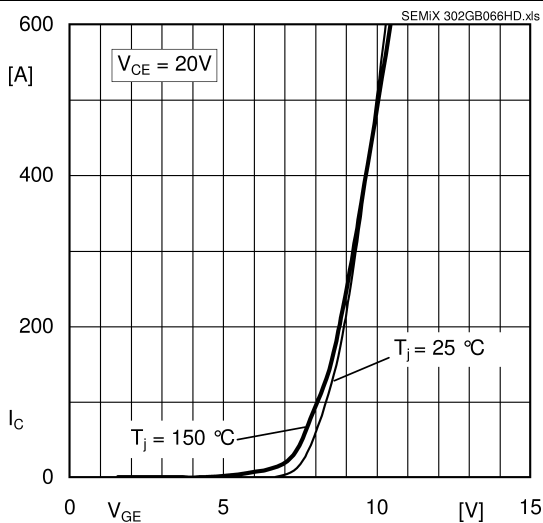


Fig. 5: Typ. transfer characteristic

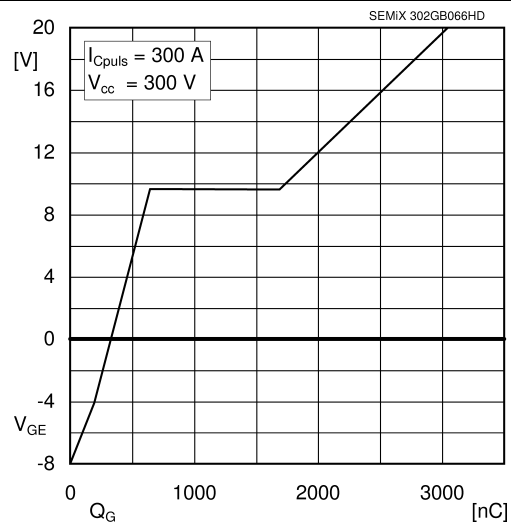


Fig. 6: Typ. gate charge characteristic

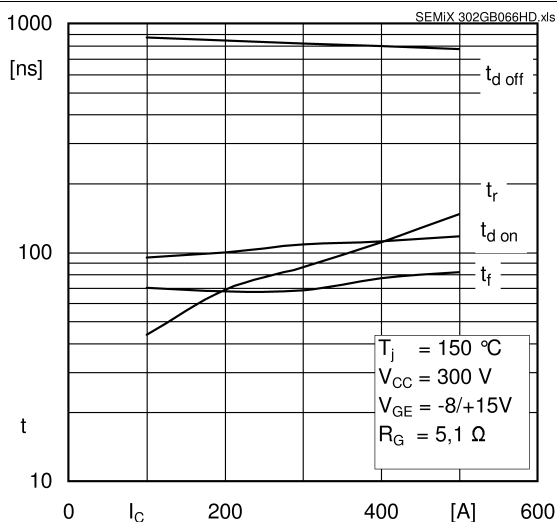


Fig. 7: Typ. switching times vs. I_C

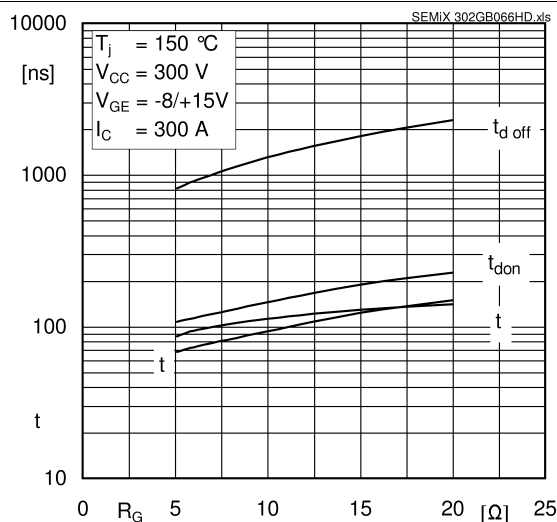


Fig. 8: Typ. switching times vs. gate resistor R_G

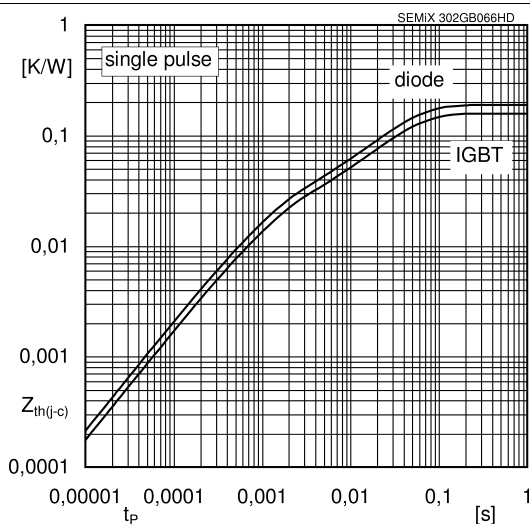


Fig. 9: Typ. transient thermal impedance

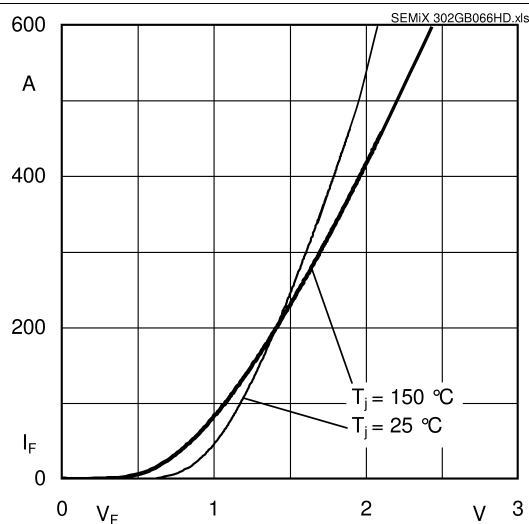


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'+EE'}$

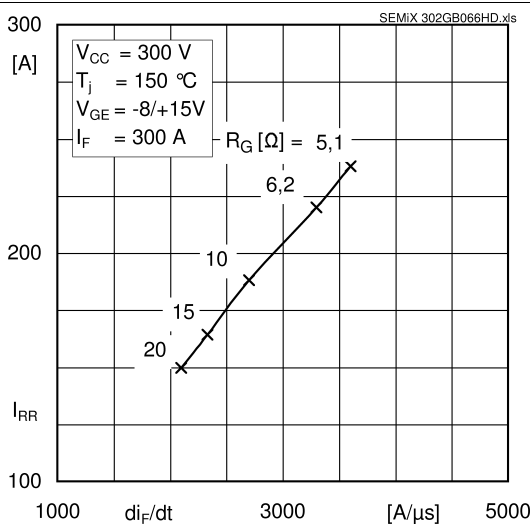


Fig. 11: Typ. CAL diode peak reverse recovery current

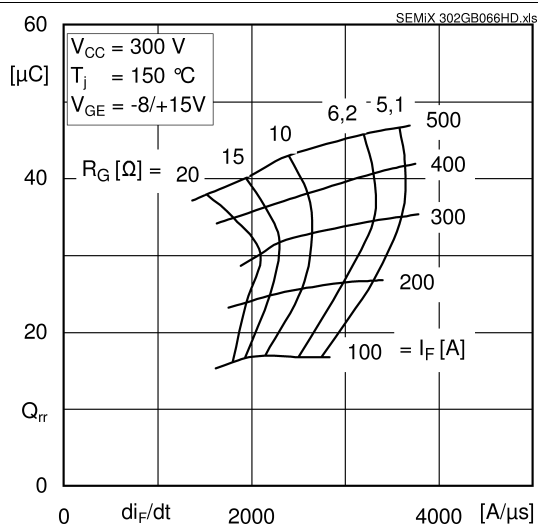
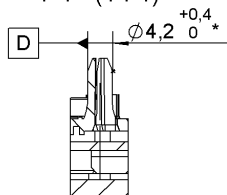


Fig. 12: Typ. CAL diode recovery charge

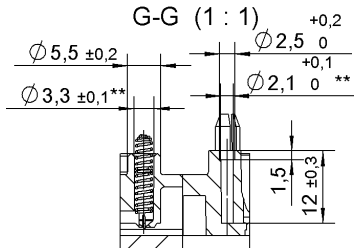
SEMiX302GB066HDs

Case: SEMiX 2s

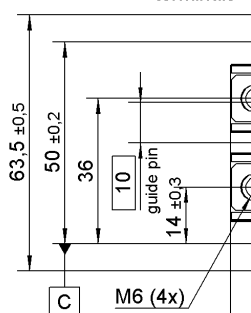
guide pin left
F-F (1 : 1)



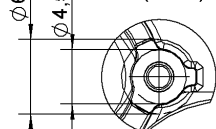
screw duct (4x)
spring duct (12x):
G-G (1 : 1)



marking of terminals



screw duct
top view (4x):
J (2 : 1)



*guide pin left with

⌀ 0,25	A	B	C
⌀ 0,5	A	D	C

**screw ducts / spring ducts / guide pin right with

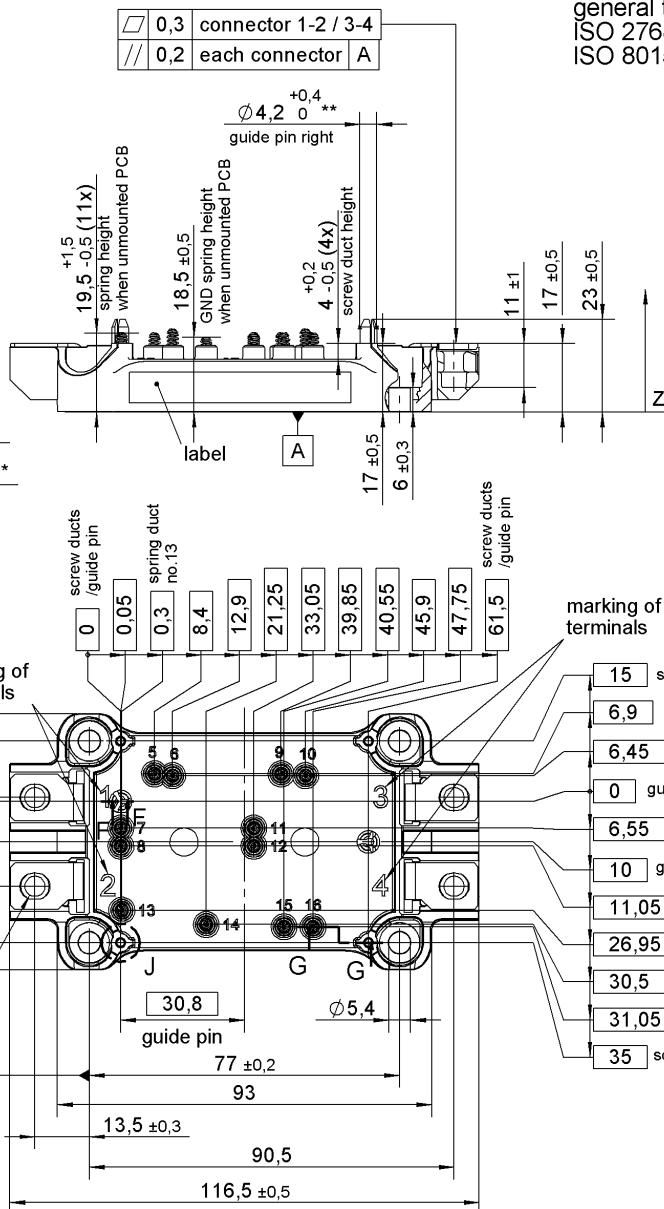
⌀ 0,25	A	B	C
⌀ 0,5	A	D	C

Rules for the contact PCB:

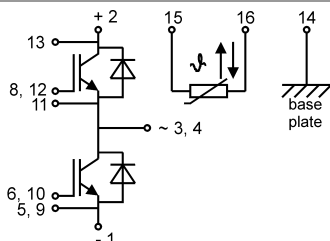
- holes guidepins = $\varnothing 4 \pm 0,1$ / position tolerance $\pm 0,1$
- holes for screws = $\varnothing 3,3 \pm 0,1$ / position tolerance $\pm 0,1$
- spring contact pad = $\varnothing 3,6 \pm 0,1$ / position tolerance $\pm 0,1$

general tolerance:
ISO 2768-m
ISO 8015

All measures in Z-direction
valid when mounted to heat sink



SEMiX 2s



spring configuration

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.